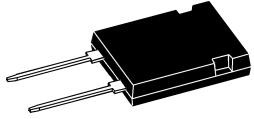


Package style		Voltage $V_{RRM}$ V	Current $I_{FAV}$ A	$t_{rr}$ ns	Type	Circuit Diagram	Page
<b>1</b> ISOPLUS 247™ 	1	<b>600</b>	9	15	<b>DSEP 9-06CR</b>		2
		<b>600</b>	17	15	<b>DSS 17-06CR</b>		3
		<b>600</b>	30	20	<b>DSEP30-06CR</b>		4
	2	<b>1200</b>	15	20	<b>DSEP15-12CR</b>		5
		<b>1200</b>	30	30	<b>DSEP30-12CR</b>		6
	2	<b>600</b>	2x35	20	<b>DSEP2x35-06C</b>		7
		<b>1200</b>	2x25	20	<b>DSEP2x25-12C</b>		8

Dimensions

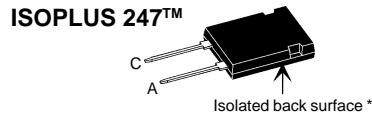
9

# HiPerDynFRED™ Epitaxial Diode with soft recovery (Electrically Isolated Back Surface)

**I<sub>FAV</sub>** = 9 A  
**V<sub>RRM</sub>** = 600 V  
**t<sub>rr</sub>** = 15 ns

## Preliminary Data

V <sub>RSM</sub>	V <sub>RRM</sub>	Type
V	V	
600	600	DSEP 9-06CR



A = Anode, C = Cathode

\* Patent pending

Symbol	Conditions	Maximum Ratings	
I <sub>FRMS</sub>		50	A
I <sub>FAVM</sub>	T <sub>C</sub> = 140°C; rectangular, d = 0.5	9	A
I <sub>FRM</sub>	t <sub>p</sub> < 10 µs; rep. rating, pulse width limited by T <sub>VJM</sub>	tbd	A
I <sub>FSM</sub>	T <sub>VJ</sub> = 45°C; t <sub>p</sub> = 10 ms (50 Hz), sine	80	A
E <sub>AS</sub>	T <sub>VJ</sub> = 25°C; non-repetitive I <sub>AS</sub> = 2 A; L = 180 µH	0.5	mJ
I <sub>AR</sub>	V <sub>A</sub> = 1.5·V <sub>R</sub> typ.; f = 10 kHz; repetitive	0.2	A
T <sub>VJ</sub>		-55...+175	°C
T <sub>VJM</sub>		175	°C
T <sub>stg</sub>		-55...+150	°C
P <sub>tot</sub>	T <sub>C</sub> = 25°C	150	W
V <sub>ISOL</sub>	50/60 Hz RMS; I <sub>ISOL</sub> ≤ 1 mA	2500	V~
F <sub>c</sub>	mounting force with clip	20...120	N
Weight	typical	6	g

Symbol	Conditions	Characteristic Values	
		typ.	max.
I <sub>R</sub> ①	T <sub>VJ</sub> = 25°C V <sub>R</sub> = V <sub>RRM</sub> T <sub>VJ</sub> = 150°C V <sub>R</sub> = V <sub>RRM</sub>	50	µA
		0.2	mA
V <sub>F</sub> ②	I <sub>F</sub> = 9 A; T <sub>VJ</sub> = 150°C T <sub>VJ</sub> = 25°C	2.9	V
		4.0	V
R <sub>thJC</sub>		1	K/W
R <sub>thCH</sub>		0.25	K/W
t <sub>rr</sub>	I <sub>F</sub> = 1 A; -di/dt = 200 A/µs; V <sub>R</sub> = 30 V; T <sub>VJ</sub> = 25°C	15	ns
I <sub>RM</sub>	V <sub>R</sub> = 100 V; I <sub>F</sub> = 10 A; -di <sub>F</sub> /dt = 100 A/µs T <sub>VJ</sub> = 100°C	3.5	4.1
			A

Pulse test: ① Pulse Width = 5 ms, Duty Cycle < 2.0 %  
② Pulse Width = 300 µs, Duty Cycle < 2.0 %

Data according to IEC 60747 and per diode unless otherwise specified

IXYS reserves the right to change limits, test conditions and dimensions.

## Features

- Silicon chip on Direct-Copper-Bond substrate
  - High power dissipation
  - Isolated mounting surface
  - 2500V electrical isolation
- Low cathode to tab capacitance (<25pF)
- International standard package
- Planar passivated chips
- Very short recovery time
- Extremely low switching losses
- Low I<sub>RM</sub> values
- Soft recovery behaviour
- Epoxy meets UL 94V-0
- Isolated and UL registered E153432

## Applications

- Antiparallel diode for high frequency switching devices
- Antisaturation diode
- Snubber diode
- Free wheeling diode in converters and motor control circuits
- Rectifiers in switch mode power supplies (SMPS)
- Inductive heating
- Uninterruptible power supplies (UPS)
- Ultrasonic cleaners and welders

## Advantages

- Avalanche voltage rated for reliable operation
- Soft reverse recovery for low EMI/RFI
- Low I<sub>RM</sub> reduces:
  - Power dissipation within the diode
  - Turn-on loss in the commutating switch

Dimensions see page D3 - 9

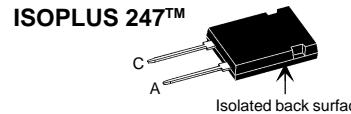
# HiPerDyn™ Schottky Diode

## (Electrically Isolated Back Surface)

**I<sub>FAV</sub> = 17 A**  
**V<sub>RRM</sub> = 600 V**  
**t<sub>rr</sub> = 45 ns**

### Preliminary Data

V <sub>RSM</sub>	V <sub>RRM</sub>	Type
V	V	
600	600	DSS 17-06CR



A = Anode, C = Cathode

\* Patent pending

Symbol	Conditions	Maximum Ratings	
I <sub>FRMS</sub>		50	A
I <sub>FAVM</sub>	T <sub>C</sub> = 95°C; rectangular, d = 0.5	17	A
I <sub>FRM</sub>	t <sub>p</sub> < 10 µs; rep. rating, pulse width limited by T <sub>VJM</sub>	tbd	A
I <sub>FSM</sub>	T <sub>VJ</sub> = 45°C; t <sub>p</sub> = 10 ms (50 Hz), sine	200	A
E <sub>AS</sub>	T <sub>VJ</sub> = 25°C; non-repetitive I <sub>AS</sub> = 2 A; L = 180 µH	tbd	mJ
I <sub>AR</sub>	V <sub>A</sub> = 1.5·V <sub>R</sub> typ.; f = 10 kHz; repetitive	tbd	A
T <sub>VJ</sub>		-55...+175	°C
T <sub>VJM</sub>		175	°C
T <sub>stg</sub>		-55...+150	°C
P <sub>tot</sub>	T <sub>C</sub> = 25°C	105	W
V <sub>ISOL</sub>	50/60 Hz RMS; I <sub>ISOL</sub> ≤ 1 mA	2500	V~
F <sub>c</sub>	mounting force with clip	20...120	N
Weight	typical	6	g

Symbol	Conditions	Characteristic Values	
		typ.	max.
I <sub>R</sub> ①	T <sub>VJ</sub> = 25°C V <sub>R</sub> = V <sub>RRM</sub> T <sub>VJ</sub> = 125°C V <sub>R</sub> = V <sub>RRM</sub>	0.5 5	mA mA
V <sub>F</sub> ②	I <sub>F</sub> = 15 A; T <sub>VJ</sub> = 125°C T <sub>VJ</sub> = 25°C	2.71 3.32	V V
R <sub>thJC</sub> R <sub>thCH</sub>		0.25	1.4 K/W K/W
t <sub>rr</sub>	I <sub>F</sub> = 10 A; -di/dt = 100 A/µs; V <sub>R</sub> = 100 V; T <sub>VJ</sub> = 25°C	45	ns
I <sub>RM</sub>	V <sub>R</sub> = 100 V; I <sub>F</sub> = 10 A; -di <sub>F</sub> /dt = 100 A/µs T <sub>VJ</sub> = 25°C	4.0	A

Pulse test: ① Pulse Width = 5 ms, Duty Cycle < 2.0 %  
 ② Pulse Width = 300 µs, Duty Cycle < 2.0 %

Data according to IEC 60747 and per diode unless otherwise specified

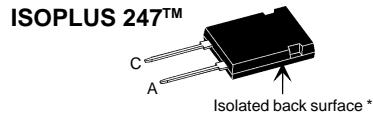
IXYS reserves the right to change limits, test conditions and dimensions.

# HiPerDynFRED™ Epitaxial Diode with soft recovery (Electrically Isolated Back Surface)

**I<sub>FAV</sub> = 30 A**  
**V<sub>RRM</sub> = 600 V**  
**t<sub>rr</sub> = 20 ns**

## Preliminary Data

V <sub>RSM</sub>	V <sub>RRM</sub>	Type
V	V	
600	600	DSEP 30-06CR



A = Anode, C = Cathode

\* Patent pending

Symbol	Conditions	Maximum Ratings	
I <sub>FRMS</sub>		70	A
I <sub>FAVM</sub>	T <sub>C</sub> = 135°C; rectangular, d = 0.5	30	A
I <sub>FRM</sub>	t <sub>p</sub> < 10 µs; rep. rating, pulse width limited by T <sub>VJM</sub>	tbd	A
I <sub>FSM</sub>	T <sub>VJ</sub> = 45°C; t <sub>p</sub> = 10 ms (50 Hz), sine	300	A
E <sub>AS</sub>	T <sub>VJ</sub> = 25°C; non-repetitive I <sub>AS</sub> = 3 A; L = 180 µH	1.2	mJ
I <sub>AR</sub>	V <sub>A</sub> = 1.5·V <sub>R</sub> typ.; f = 10 kHz; repetitive	0.3	A
T <sub>VJ</sub>		-55...+175	°C
T <sub>VJM</sub>		175	°C
T <sub>stg</sub>		-55...+150	°C
P <sub>tot</sub>	T <sub>C</sub> = 25°C	250	W
V <sub>ISOL</sub>	50/60 Hz RMS; I <sub>ISOL</sub> ≤ 1 mA	2500	V~
F <sub>c</sub>	mounting force with clip	20...120	N
Weight	typical	6	g

Symbol	Conditions	Characteristic Values	
		typ.	max.
I <sub>R</sub> ①	T <sub>VJ</sub> = 25°C V <sub>R</sub> = V <sub>RRM</sub> T <sub>VJ</sub> = 150°C V <sub>R</sub> = V <sub>RRM</sub>	250	µA
		1	mA
V <sub>F</sub> ②	I <sub>F</sub> = 30 A; T <sub>VJ</sub> = 150°C T <sub>VJ</sub> = 25°C	1.79	V
		2.46	V
R <sub>thJC</sub>		0.6	K/W
R <sub>thCH</sub>	with heatsink compound	0.25	K/W
t <sub>rr</sub>	I <sub>F</sub> = 1 A; -di/dt = 200 A/µs; V <sub>R</sub> = 30 V; T <sub>VJ</sub> = 25°C	20	ns
I <sub>RM</sub>	V <sub>R</sub> = 100 V; I <sub>F</sub> = 50 A; -di <sub>F</sub> /dt = 100 A/µs T <sub>VJ</sub> = 100°C	4.5	7.0
			A

Pulse test: ① Pulse Width = 5 ms, Duty Cycle < 2.0 %  
 ② Pulse Width = 300 µs, Duty Cycle < 2.0 %

Data according to IEC 60747 and per diode unless otherwise specified

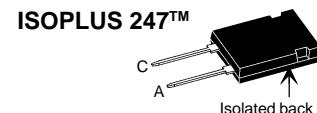
IXYS reserves the right to change limits, test conditions and dimensions.

# HiPerDynFRED™ Epitaxial Diode with soft recovery (Electrically Isolated Back Surface)

**I<sub>FAV</sub> = 15 A**  
**V<sub>RRM</sub> = 1200 V**  
**t<sub>rr</sub> = 20 ns**

## Preliminary Data

V <sub>RSM</sub> V	V <sub>RRM</sub> V	Type
1200	1200	DSEP 15-12CR



A = Anode, C = Cathode

\* Patent pending

Symbol	Conditions	Maximum Ratings	
I <sub>FRMS</sub>		50	A
I <sub>FAVM</sub>	T <sub>C</sub> = 130°C; rectangular, d = 0.5	15	A
I <sub>FRM</sub>	t <sub>p</sub> < 10 µs; rep. rating, pulse width limited by T <sub>VJM</sub>	tbd	A
I <sub>FSM</sub>	T <sub>VJ</sub> = 45°C; t <sub>p</sub> = 10 ms (50 Hz), sine	110	A
E <sub>AS</sub>	T <sub>VJ</sub> = 25°C; non-repetitive I <sub>AS</sub> = 1.0 A; L = 180 µH	0.1	mJ
I <sub>AR</sub>	V <sub>A</sub> = 1.25·V <sub>R</sub> typ.; f = 10 kHz; repetitive	0.1	A
T <sub>VJ</sub>		-55...+175	°C
T <sub>VJM</sub>		175	°C
T <sub>stg</sub>		-55...+150	°C
P <sub>tot</sub>	T <sub>C</sub> = 25°C	150	W
V <sub>ISOL</sub>	50/60 Hz RMS; I <sub>ISOL</sub> ≤ 1 mA	2500	V~
F <sub>c</sub>	mounting force with clip	20...120	N
Weight	typical	6	g

Symbol	Conditions	Characteristic Values	
		typ.	max.
I <sub>R</sub> ①	T <sub>VJ</sub> = 25°C V <sub>R</sub> = V <sub>RRM</sub> T <sub>VJ</sub> = 150°C V <sub>R</sub> = V <sub>RRM</sub>	100 0.5	µA mA
V <sub>F</sub> ②	I <sub>F</sub> = 15 A; T <sub>VJ</sub> = 150°C T <sub>VJ</sub> = 25°C	2.67 4.04	V V
R <sub>thJC</sub> R <sub>thCH</sub>	with heatsink compound	0.25	1 K/W K/W
t <sub>rr</sub>	I <sub>F</sub> = 1 A; -di/dt = 200 A/µs; V <sub>R</sub> = 30 V; T <sub>VJ</sub> = 25°C	20	ns
I <sub>RM</sub>	V <sub>R</sub> = 100 V; I <sub>F</sub> = 25 A; -di <sub>F</sub> /dt = 100 A/µs T <sub>VJ</sub> = 100°C	4.0	4.9 A

Pulse test: ① Pulse Width = 5 ms, Duty Cycle < 2.0 %  
 ② Pulse Width = 300 µs, Duty Cycle < 2.0 %

Data according to IEC 60747 and per diode unless otherwise specified

IXYS reserves the right to change limits, test conditions and dimensions.

## Features

- Silicon chip on Direct-Copper-Bond substrate
  - High power dissipation
  - Isolated mounting surface
  - 2500V electrical isolation
- Low cathode to tab capacitance (<25pF)
- International standard package
- Planar passivated chips
- Very short recovery time
- Extremely low switching losses
- Low I<sub>RM</sub>-values
- Soft recovery behaviour
- Epoxy meets UL 94V-0
- Isolated and UL registered E153432

## Applications

- Antiparallel diode for high frequency switching devices
- Antisaturation diode
- Snubber diode
- Free wheeling diode in converters and motor control circuits
- Rectifiers in switch mode power supplies (SMPS)
- Inductive heating
- Uninterruptible power supplies (UPS)
- Ultrasonic cleaners and welders

## Advantages

- Avalanche voltage rated for reliable operation
- Soft reverse recovery for low EMI/RFI
- Low I<sub>RM</sub> reduces:
  - Power dissipation within the diode
  - Turn-on loss in the commutating switch

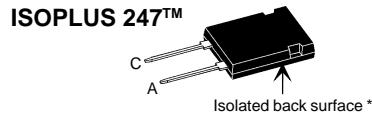
Dimensions see page D3 - 9

# HiPerDynFRED™ Epitaxial Diode with soft recovery (Electrically Isolated Back Surface)

**I<sub>FAV</sub>** = 30 A  
**V<sub>RRM</sub>** = 1200 V  
**t<sub>rr</sub>** = 20 ns

## Preliminary Data

V <sub>RSM</sub>	V <sub>RRM</sub>	Type
V	V	
1200	1200	DSEP 30-12CR



A = Anode, C = Cathode

\* Patent pending

Symbol	Conditions	Maximum Ratings	
I <sub>FRMS</sub>		70	A
I <sub>FAVM</sub>	T <sub>C</sub> = 115°C; rectangular, d = 0.5	30	A
I <sub>FRM</sub>	t <sub>p</sub> < 10 µs; rep. rating, pulse width limited by T <sub>VJM</sub>	tbd	A
I <sub>FSM</sub>	T <sub>VJ</sub> = 45°C; t <sub>p</sub> = 10 ms (50 Hz), sine	250	A
E <sub>AS</sub>	T <sub>VJ</sub> = 25°C; non-repetitive	0.2	mJ
	I <sub>AS</sub> = 1.3 A; L = 180 µH		
I <sub>AR</sub>	V <sub>A</sub> = 1.25·V <sub>R</sub> typ.; f = 10 kHz; repetitive	0.1	A
T <sub>VJ</sub>		-55...+175	°C
T <sub>VJM</sub>		175	°C
T <sub>stg</sub>		-55...+150	°C
P <sub>tot</sub>	T <sub>C</sub> = 25°C	250	W
V <sub>ISOL</sub>	50/60 Hz RMS; I <sub>ISOL</sub> ≤ 1 mA	2500	V~
F <sub>c</sub>	mounting force with clip	20...120	N
Weight	typical	6	g

Symbol	Conditions	Characteristic Values	
		typ.	max.
I <sub>R</sub> ①	T <sub>VJ</sub> = 25°C V <sub>R</sub> = V <sub>RRM</sub> T <sub>VJ</sub> = 150°C V <sub>R</sub> = V <sub>RRM</sub>	250	µA
		2	mA
V <sub>F</sub> ②	I <sub>F</sub> = 30 A; T <sub>VJ</sub> = 150°C T <sub>VJ</sub> = 25°C	3.1	V
		5.0	V
R <sub>thJC</sub>		0.6	K/W
R <sub>thCH</sub>	with heatsink compound	0.25	K/W
t <sub>rr</sub>	I <sub>F</sub> = 1 A; -di/dt = 200 A/µs; V <sub>R</sub> = 30 V; T <sub>VJ</sub> = 25°C	20	ns
I <sub>RM</sub>	V <sub>R</sub> = 100 V; I <sub>F</sub> = 50 A; -di <sub>F</sub> /dt = 100 A/µs T <sub>VJ</sub> = 100°C	4.0	A

Pulse test: ① Pulse Width = 5 ms, Duty Cycle < 2.0 %  
② Pulse Width = 300 µs, Duty Cycle < 2.0 %

Data according to IEC 60747 and per diode unless otherwise specified

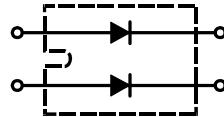
IXYS reserves the right to change limits, test conditions and dimensions.

# HiPerDynFRED™ Epitaxial Diode with soft recovery

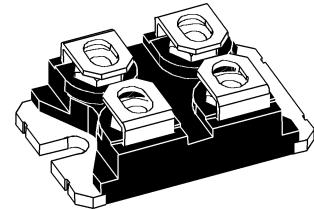
**I<sub>FAV</sub>** = 2x 35 A  
**V<sub>RRM</sub>** = 600 V  
**t<sub>rr</sub>** = 20 ns

## Preliminary Data

V <sub>RSM</sub>	V <sub>RRM</sub>	Type
V	V	
600	600	DSEP 2x 35-06C



miniBLOC, SOT-227 B



Symbol	Test Conditions	Maximum Ratings	
I <sub>FRMS</sub>		100	A
I <sub>FAVM</sub>	T <sub>C</sub> = 100°C; rectangular, d = 0.5	35	A
I <sub>FRM</sub>	t <sub>p</sub> < 10 µs; rep. rating, pulse width limited by T <sub>VJM</sub>	tbd	A
I <sub>FSM</sub>	T <sub>VJ</sub> = 45°C; t <sub>p</sub> = 10 ms (50 Hz), sine	300	A
E <sub>AS</sub>	T <sub>VJ</sub> = 25°C; non-repetitive I <sub>AS</sub> = 3 A; L = 180 µH	1.2	mJ
I <sub>AR</sub>	V <sub>A</sub> = 1.5·V <sub>R</sub> typ.; f = 10 kHz; repetitive	0.3	A
T <sub>VJ</sub>		-40...+150	°C
T <sub>VJM</sub>		150	°C
T <sub>stg</sub>		-40...+150	°C
P <sub>tot</sub>	T <sub>C</sub> = 25°C	210	W
V <sub>ISOL</sub>	50/60 Hz, RMS, I <sub>ISOL</sub> ≤ 1 mA	2500	V~
M <sub>d</sub>	mounting torque (M4) terminal connection torque (M4)	1.1-1.5/9-13 1.1-1.5/9-13	Nm/lb.in. Nm/lb.in.
Weight	typical	30	g

Symbol	Test Conditions	Characteristic Values	
		typ.	max.
I <sub>R</sub> ①	V <sub>R</sub> = V <sub>RRM</sub> ; T <sub>VJ</sub> = 25°C T <sub>VJ</sub> = 150°C	0.25 1.0	mA mA
V <sub>F</sub> ②	I <sub>F</sub> = 35 A; T <sub>VJ</sub> = 125°C T <sub>VJ</sub> = 25°C	1.97 2.50	V V
R <sub>thJC</sub>		0.6	K/W
R <sub>thCH</sub>	with heatsink compound	0.1	K/W
t <sub>rr</sub>	I <sub>F</sub> = 1 A; -di/dt = 300 A/µs; V <sub>R</sub> = 30 V; T <sub>VJ</sub> = 25°C	20	ns
I <sub>RM</sub>	V <sub>R</sub> = 100 V; I <sub>F</sub> = 50 A; -di <sub>F</sub> /dt = 100 A/µs T <sub>VJ</sub> = 100°C	4.5	7.0 A

Pulse test: ① Pulse Width = 5 ms, Duty Cycle < 2.0 %  
② Pulse Width = 300 µs, Duty Cycle < 2.0 %

Data according to IEC 60747 and per diode unless otherwise specified

IXYS reserves the right to change limits, test conditions and dimensions.

## Features

- International standard package miniBLOC
- Isolation voltage 2500 V~
- UL registered E 72873
- 2 independent FRED in 1 package
- Planar passivated chips
- Very short recovery time
- Extremely low switching losses
- Low I<sub>RM</sub>-values
- Soft recovery behaviour

## Applications

- Antiparallel diode for high frequency switching devices
- Antisaturation diode
- Snubber diode
- Free wheeling diode in converters and motor control circuits
- Rectifiers in switch mode power supplies (SMPS)
- Inductive heating
- Uninterruptible power supplies (UPS)
- Ultrasonic cleaners and welders

## Advantages

- Avalanche voltage rated for reliable operation
- Soft reverse recovery for low EMI/RFI
- Low I<sub>RM</sub> reduces:
  - Power dissipation within the diode
  - Turn-on loss in the commuting switch

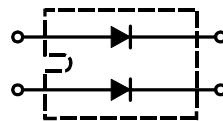
Dimensions see page D3 - 9

# HiPerDynFRED™ Epitaxial Diode with soft recovery

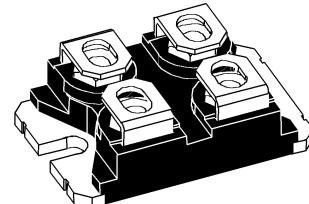
**I<sub>FAV</sub>** = 2x 25 A  
**V<sub>RRM</sub>** = 1200 V  
**t<sub>rr</sub>** = 20 ns

## Preliminary Data

V <sub>RSM</sub>	V <sub>RRM</sub>	Type
V	V	
1200	1200	DSEP 2x 25-12C



miniBLOC, SOT-227 B



Symbol	Test Conditions	Maximum Ratings	
I <sub>FRMS</sub>		100	A
I <sub>FAVM</sub>	T <sub>C</sub> = 95°C; rectangular, d = 0.5	25	A
I <sub>FRM</sub>	t <sub>p</sub> < 10 µs; rep. rating, pulse width limited by T <sub>VJM</sub>	tbd	A
I <sub>FSM</sub>	T <sub>VJ</sub> = 45°C; t <sub>p</sub> = 10 ms (50 Hz), sine	250	A
E <sub>AS</sub>	T <sub>VJ</sub> = 25°C; non-repetitive I <sub>AS</sub> = 1.3 A; L = 180 µH	0.2	mJ
I <sub>AR</sub>	V <sub>A</sub> = 1.5·V <sub>R</sub> typ.; f = 10 kHz; repetitive	0.1	A
T <sub>VJ</sub>		-40...+150	°C
T <sub>VJM</sub>		150	°C
T <sub>stg</sub>		-40...+150	°C
P <sub>tot</sub>	T <sub>C</sub> = 25°C	210	W
V <sub>ISOL</sub>	50/60 Hz, RMS, I <sub>ISOL</sub> ≤ 1 mA	2500	V~
M <sub>d</sub>	mounting torque (M4) terminal connection torque (M4)	1.1-1.5/9-13 1.1-1.5/9-13	Nm/lb.in Nm/lb.in
Weight	typical	30	g

Symbol	Test Conditions	Characteristic Values	
		typ.	max.
I <sub>R</sub> ①	V <sub>R</sub> = V <sub>RRM</sub> ; T <sub>VJ</sub> = 25°C T <sub>VJ</sub> = 150°C	0.25 2.0	mA mA
V <sub>F</sub> ②	I <sub>F</sub> = 25 A; T <sub>VJ</sub> = 125°C T <sub>VJ</sub> = 25°C	3.30 4.80	V V
R <sub>thJC</sub> R <sub>thCH</sub>	with heatsink compound	0.1	K/W K/W
t <sub>rr</sub>	I <sub>F</sub> = 1 A; -di/dt = 200 A/µs; V <sub>R</sub> = 30 V; T <sub>VJ</sub> = 25°C	20	ns
I <sub>RM</sub>	V <sub>R</sub> = 100 V; I <sub>F</sub> = 50 A; -di <sub>F</sub> /dt = 100 A/µs T <sub>VJ</sub> = 100°C	4.0	A

Pulse test: ① Pulse Width = 5 ms, Duty Cycle < 2.0 %  
② Pulse Width = 300 µs, Duty Cycle < 2.0 %

Data according to IEC 60747 and per diode unless otherwise specified

IXYS reserves the right to change limits, test conditions and dimensions.

## Features

- International standard package miniBLOC
- Isolation voltage 2500 V~
- UL registered E 72873
- 2 independent FRED in 1 package
- Planar passivated chips
- Very short recovery time
- Extremely low switching losses
- Low I<sub>RM</sub>-values
- Soft recovery behaviour

## Applications

- Antiparallel diode for high frequency switching devices
- Antisaturation diode
- Snubber diode
- Free wheeling diode in converters and motor control circuits
- Rectifiers in switch mode power supplies (SMPS)
- Inductive heating
- Uninterruptible power supplies (UPS)
- Ultrasonic cleaners and welders

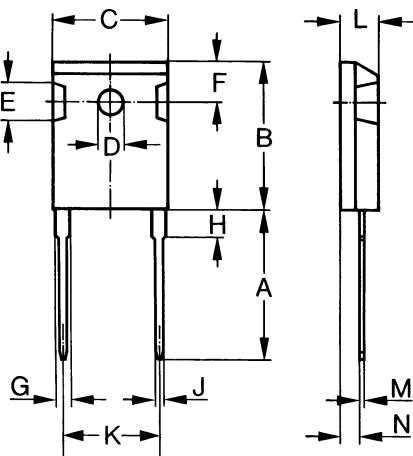
## Advantages

- Avalanche voltage rated for reliable operation
- Soft reverse recovery for low EMI/RFI
- Low I<sub>RM</sub> reduces:
  - Power dissipation within the diode
  - Turn-on loss in the commutating switch

Dimensions see page D3 - 9

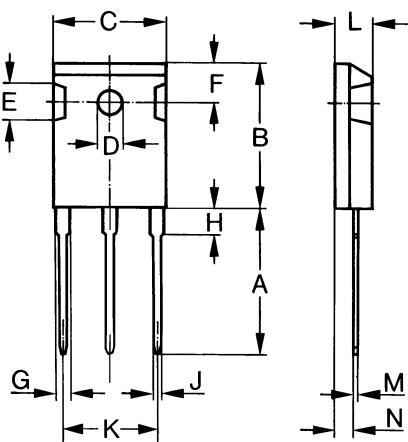
## Dimensions

**TO-247 AD and ISOPLUS 247™**



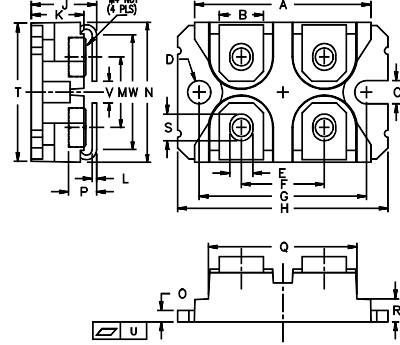
Dim.	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	19.81	20.32	0.780	0.800
B	20.80	21.46	0.819	0.845
C	15.75	16.26	0.610	0.640
D*	3.55	3.65	0.140	0.144
E	4.32	5.49	0.170	0.216
F	5.4	6.2	0.212	0.244
G	1.65	2.13	0.065	0.084
H	-	4.5	-	0.177
J	1.0	1.4	0.040	0.055
K	10.8	11.0	0.426	0.433
L	4.7	5.3	0.185	0.209
M	0.4	0.8	0.016	0.031
N	1.5	2.49	0.087	0.102

**TO-247 AD and ISOPLUS 247™**



\* ISOPLUS 247™ without hole

**miniBLOC, SOT-227 B**



M4 screws (4x) supplied

Dim.	Millimeter Min.	Millimeter Max.	Inches Min.	Inches Max.
A	31.50	31.88	1.240	1.255
B	7.80	8.20	0.307	0.323
C	4.09	4.29	0.161	0.169
D	4.09	4.29	0.161	0.169
E	4.09	4.29	0.161	0.169
F	14.91	15.11	0.587	0.595
G	30.12	30.30	1.186	1.193
H	37.80	38.20	1.489	1.505
J	11.68	12.22	0.460	0.481
K	8.92	9.60	0.351	0.378
L	0.76	0.84	0.030	0.033
M	12.60	12.85	0.496	0.506
N	25.15	25.42	0.990	1.001
O	1.98	2.13	0.078	0.084
P	4.95	5.97	0.195	0.235
Q	26.54	26.90	1.045	1.059
R	3.94	4.42	0.155	0.174
S	4.72	4.85	0.186	0.191
T	24.59	25.07	0.968	0.987
U	-0.05	0.1	-0.002	0.004
V	3.30	4.57	0.130	0.180
W	0.780	0.830	0.19.81	21.08

